

FORM PTO 1449 (modified)

ATTY DOCKET NO.
50169/105/ENPOSERIAL NO.
08/401,229U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT

J. Lee Wallace T. Y. Tang

FILING DATE
March 9, 1995GROUP
2501- 2874

Date Submitted to PTO: August 16, 1995

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JDL	A1	3,510,667	06/67	Cleveland et al.	250	227.26	
JDL	A2	3,986,777	10/76	Roll	356	405	
JDL	A3	4,672,200	06/87	Claypool et al.	250	227.23 XR	
JDL	A4	4,929,828	05/90	Claypool	280	223 B	
JDL	A5	5,081,796	01/92	SCHULTZ	451	165.74 8	
JDL	A6	5,081,421	01/92	MILLER et al.	324	631 671	
JDL	A7	5,069,002	12/91	SANDHU et al.	451	165 R 1	
JDL	A8	5,036,015	07/06/91	SANDHU et al.	437	8	
JDL	A9	4,879,258	11/89	FISHER	437	225	
JDL	A10	4,793,895	12/88	KAANTA et al.	156	627.1	
JDL	A11	4,569,717	02/86	OHGAMI et al.	150 216	620 85	
JDL	A12	4,436,367	03/84	LEWIS et al.	350 385	96.20 26	
JDL	A13	4,398,791	08/83	DORSEY	350 385	96.10 26	
JDL	A14	5,120,966	06/92	KONDO	356	381 XR	
JDL	A15	4,713,140	12/87	TIEN	356	381 XR	
JDL	A16	4,529,986	07/85	d'AURIA et al.	385	25 XR	
JDL	A17	3,510,667	05/70	CLEVELAND et al.	385	26 XR	
JDL	A18	4,999,509	03/91	WADA et al.	356	381 XR	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
JDL	A19	59-57215(A)	04/1984	Japan			Abstract

EXAMINER

JOHN D. LEE John D. Lee

DATE CONSIDERED

07 FEBRUARY 1996

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.
 Include copy of this form with next communication to applicant.

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2501-2874

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER		NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ADL	A20	3,623,813	11/71	HAEMAN	356	357	
ADL	A21	4,618,262	10/86	MAYDAN et al.	356	355 XR	
ADL	A22	5,046,849	09/91	SEVERIN et al.	356	355 XR	
ADL	A23	4,998,021	03/91	MIMASAKA	356	357 XR	
ADL	A24	2,973,686	03/61	DREYFUS et al.	356	355	
ADL	A25	2,578,859	12/51	TEEPLE et al.	356	357	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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